



Smart solution for testing measurements



The most suitable acquisition solution for your testcell

Software & Testing Solutions (STS) MIO™ Acquisition range has been developed to provide a high level of integration with MORPHEE® automation system. Featuring excellent acquisition and control performances thanks to the EtherCAT technology, it is the perfect solution for measurement boombox or mobile measurement racks of test beds but also for embedded applications including e-mobility.

With STS solutions, boost your acquisition capacities!

MIO[™] product range provides performant, robust and accurate measurements of all relevant signals in any kind of test beds.



(Ethernet for Control and

Automation Technology) is an Ethernet solution for industrial automation offering exceptional performance while being very easy to use. The master bus requires no additional extension board, and can be easily implemented on any Ethernet adapter. EtherCAT is especially well-suited for control-command systems that use remote I/O, such as automotive test cells.

Your benefits

- High integration with MORPHEE®
- Direct EtherCat connectivity
- Compact and modular
- Simple and reliable
- Easy maintenance and updates



MIO A03

MIO A04

- 8 Analog inputs module
- ±50 V, ±30 V, ±10 V, ± 5 V, ± 2 V, ± 1 V or 0...25 mA
- 24 bit resolution
- 20 kHz sampling rate per channel
- Binder 8 pins plugs
- +9...30 VDC supply

- 8 Analog outputs module
- ±10 V or 0...20 mA
- 16 bit resolution
- 20 kHz sampling rate per channel
- 500 Vpk isolation channel by channel
- Binder 7 pins plugs
- +9...30 VDC supply



MIO A06



MIO F01

- 8 Insulated analog inputs module
- ±50 V, ±30 V, ±10 V, ±5 V, ±2 V, ±1 V, or 0...25 mA
- 24 bit resolution
- 20 kHz sampling rate per channel
- Binder 8 pins plugs
- +9...30 VDC supply

- 4 Frequency inputs rack
- 0.2 Hz to 360 kHz
- Torque, speed, acyclism, position or frequency measurements
- Binder 12 pins, DIN8 and BNC plugs
- +9 ... 30 V supply



MIO D01

- 16 Digital channels module
- 8 x TTL or HTL inputs PWM, Period and frequency measuring
- 8 x TTL or relay outputs PWM, state and frequency control up to 100 kHz
- Sensor supply 5 VDC
- 20 kHz sampling rate per channel
- Weidmuller terminal with clamps
- +9...30 VDC supply



MIO D02

- 16 Digital inputs module
- TTL or HTL
- PWM, period and frequency measuring
- Sensor supply 5 VDC
- 20 kHz sampling rate per channel
- 500 Vpk isolation (2 by 2)
- Weidmuller terminal with clamps
- +9...30 VDC supply



MIO D03



MIO D04

- 16 Digital outputs module
- Solid-state relays 500 mA / 50 V (dry contact)
- TTL 0...5 V
- SENT, PWM, state and frequency
- control up to 360 kHz
- Sensor supply 5 Vdc
- 20 kHz sampling rate per channel
- Weidmuller terminal with clamps
- +9...30 VDC supply

- 8 Digital outputs module
- Electromechanical relays
- 8 A / 100 V (dry contact)
- State control
- 20 kHz sampling rate per channel
- 500 Vpk isolation channel by channel
- Weidmuller terminal with clamps
- +9...30 VDC supply



MIO R02

MIO R03s

- 8 Resistance inputs module
- 2, 3 or 4 wires
- PT100, PT1000 or Potentiometer
- 24 bit resolution
- 100 Hz sampling rate per channel
- 500 Vpk isolation channel by channel
- Binder 8 pins plugs
- +9...30 VDC supply

- 8 Resistance outputs module
- 10 Ω to 1 MΩ
- 0.25 Ω resolution
- 5 Hz sampling rate per channel
- 500 Vpk insulation channel by channel
- Banana plugs
- +9 ... 30 V supply



MIO T10

- - **MIO T11**

- 16 Thermocouples module
- Type: K, J, T, E, N, R, S, B
- 24 bit resolution
- 100 Hz sampling rate per channel
- 500 Vpk isolation channel by channel
- Mini TCU plugs
- +9...30 VDC supply

- 16 Thermocouples module
- Type: K
- 24 bit resolution
- 100 Hz sampling rate per channel
- 500 Vpk isolation channel by channel
- Mini TCK plugs
- +9...30 VDC supply



MIO A05

- 16 Analog inputs rack
- ± 50 V, ± 30 V, ± 10 V, ± 5 V, ± 2 V, ± 1 V or 0...25 mA
- 24 bit resolution
- 20 kHz sampling rate per channel
- 500 Vpk isolation channel by channel
- Binder 8 pins plugs (Variant A07 Binder 6 pins; variant A09 – M12 A 8 pins – quantity 20 min)
- +9...30 VDC supply



MIO P03

- 8 Analog inputs rack dedicated to pressure transducers
- 10
- ± 10 V, 0...25 mA

- 24 bit resolution
- 20 kHz sampling rate per channel
- +9 ... 30 V supply



MIO P04

- 8 Analog inputs rack dedicated to pressure transducers
- 2 U
- ± 10 V, 0...25 mA

- 24 bit resolution
- 20 kHz sampling rate per channel
- +9 ... 30 V supply

HIGH VOLTAGE MIO RACKS



MIO All

- 4 x High voltage Inputs 4 x Current sensors Channels
- ± 1400 V, ± 700 V, ± 280 V, ± 140 V
- 1000 V CAT III
- Banana plugs (4mm)
- ± 2000 A, ± 50 A (HIOKI Current transducers)

- ± 10 V, ± 5 V, ± 2 V, ± 1 V or ±25 mA
- 60 Vdc 500 Vpk
- BNC & ME15W
- 24 bit resolution
- 500 kHz sampling rate per channel
- +10...+30 Vdc



MIO A12

- 16 x Isolated analog inputs Channels
- ± 100 V, ± 30 V, ± 10 V, ± 3 V
- 24 bit resolution
- 20 kHz sampling rate per channel
- Isolation: 1000 V CAT II & 600 V CATIII
- Banana plugs (4mm)
- +9...+30 Vdc



DYNABOX

"A universal box for the monitoring of all STS dynamometers"



The DYNABOX is dedicated to the monitoring management of STS DYNACRAFT dynamometers. This unit integrates a lot of channels for dedicated monitoring functions: Torque, Speed, PT100, PTC, Vibration measurements or digital inputs.

DYNABOX TECHNICAL DATA

Technical specifications

Inputs:

- 4 x PT100
- 2 x PTC / PT1000 / PT100
- 4 x Digital input
- 4 x Vibration 4-20 mA
- 1 x Speed (Incremental encoder)
- 1x Torque (Frequency signal)
- 3 x Slots for optional input

Outputs:

- 4 x Digital output (Dry contact)
- 1 x Summary digital output (Relay)
- 2 x Speed in Frequency (Input copy)
- 1x Torque in Frequency (Input copy)
- 1 x Torque in Voltage (Measurement value)

Interfaces:

- Ethernet (Web server)
- EtherCAT
- Power supply: 9-30 Vdc
- Operating temperature: -20...+60°C
- Protection class: IP54
- EMC: IEC61326-1
- Size (W x H x D): 410 x 250 x 110 mm
- Weight: ~ 5,0 kg
- Scope of supply
- 1 x DynaBox
- 1 x User manual in English or in French

Are you interested in innovative, pioneering software solutions?

Contact us!

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